

Notice of References Cited

Application/Control No.

09/842,161

Applicant(s)/Patent Under
Reexamination
IWAI ET AL.

Examiner

Gina C. Yu

Art Unit

1617

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6066316	05-2000	Shiojima et al.	--
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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